

TOSHIBA FIELD EFFECT TRANSISTOR SILICON N CHANNEL DUAL GATE MOS TYPE

3SK126

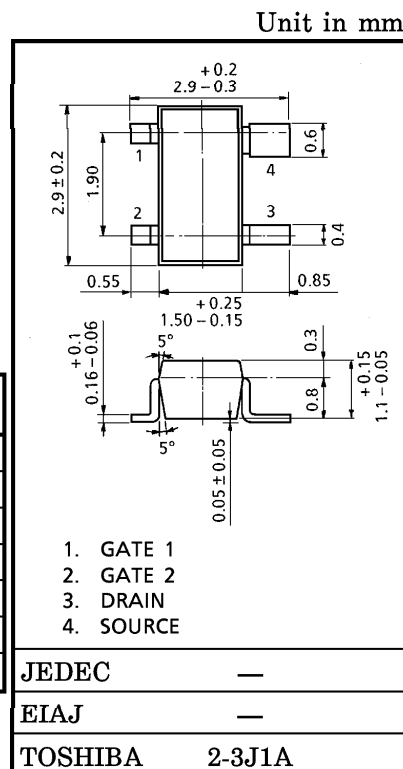
TV TUNER, VHF RF AMPLIFIER APPLICATIONS

TV TUNER VHF MIXER APPLICATIONS

- Superior Cross Modulation Performance.
- Low Reverse Transfer Capacitance : $C_{rss}=0.03\text{pF}$ (Typ.)
- Low Noise Figure : $NF=1.4\text{dB}$ (Typ.)

MAXIMUM RATINGS ($T_a = 25^\circ\text{C}$)

CHARACTERISTIC	SYMBOL	RATING	UNIT
Drain-Source Voltage	V_{DS}	15	V
Gate 1-Source Voltage	V_{G1S}	± 9	V
Gate 2-Source Voltage	V_{G2S}	± 9	V
Drain Current	I_D	30	mA
Drain Power Dissipation	P_D	150	mW
Chanel Temperature	T_{ch}	125	$^\circ\text{C}$
Storage Temperature Range	T_{stg}	$-55\sim 125$	$^\circ\text{C}$

ELECTRICAL CHARACTERISTICS ($T_a = 25^\circ\text{C}$)

Weight : 0.013g

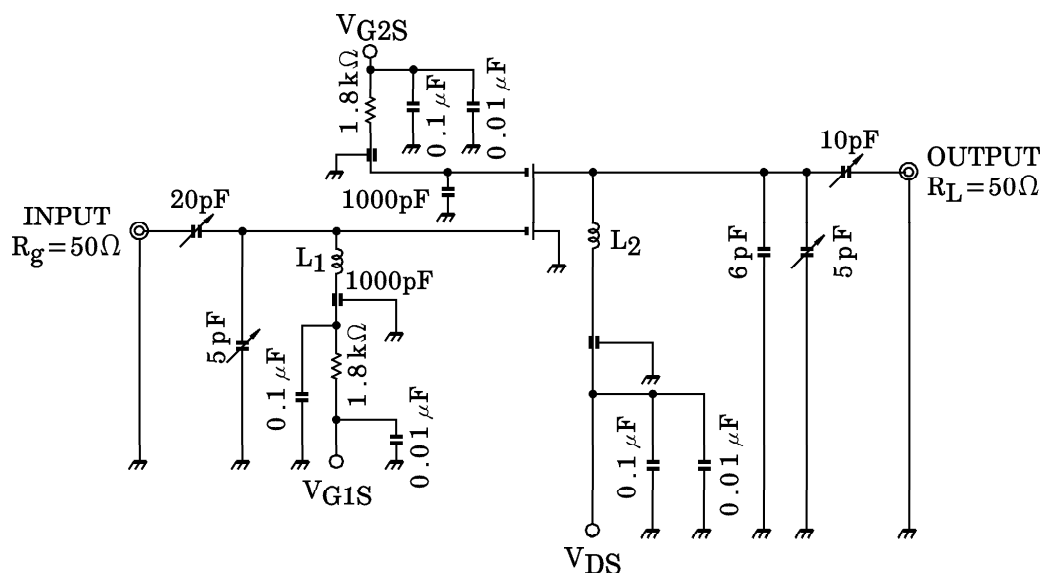
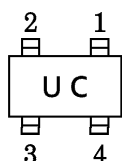
CHARACTERISTIC	SYMBOL	TEST CONDITION	MIN.	TYP.	MAX.	UNIT
Gate 1 Leakage Current	I_{G1SS}	$V_{DS}=0, V_{G1S}=\pm 7V, V_{G2S}=0$	—	—	± 50	nA
Gate 2 Leakage Current	I_{G2SS}	$V_{DS}=0, V_{G1S}=0, V_{G2S}=\pm 7V$	—	—	± 50	nA
Drain-Source Voltage	$V_{(BR)DSX}$	$V_{G1S}=-4V, V_{G2S}=-4V, I_D=100\mu A$	15	—	—	V
Drain Current	I_{DSS} (Note)	$V_{DS}=6V, V_{G1S}=0, V_{G2S}=3V$	0	—	6	mA
Gate 1-Source Cut-off Voltage	$V_{G1S(OFF)}$	$V_{DS}=6V, V_{G2S}=3V, I_D=100\mu A$	-1	—	1	V
Gate 2-Source Cut-off Voltage	$V_{G2S(OFF)}$	$V_{DS}=6V, V_{G1S}=3V, I_D=100\mu A$	-0.5	—	1	V
Forward Transfer Admittance	$ y_{fs} $	$V_{DS}=6V, V_{G2S}=3V, I_D=10\text{mA}, f=1\text{kHz}$	13	20	—	mS
Input Capacitance	C_{iss}	$V_{DS}=6V, V_{G2S}=3V, I_D=10\text{mA}, f=1\text{MHz}$	—	4.25	5.5	pF
Reverse Transfer Capacitance	C_{rss}		—	0.03	0.05	pF
Power Gain	G_{ps}	$V_{DS}=6V, V_{G2S}=3V, I_D=10\text{mA}, f=200\text{MHz}$	20	25	—	dB
Noise Figure	NF		—	1.4	2.8	dB

Note : I_{DSS} Classification O : 0~2mA, Y : 1~6mA

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Marking



L_1 : 1mm ϕ Ag Plated Copper Wire, 2 Turns, 8mm I_D
 L_2 : 1mm ϕ Ag Plated Copper Wire, 2.5 Turns, 8mm I_D

Fig.1 200MHz G_{ps} , NF TEST CIRCUIT

